

SN54ACT1284, SN74ACT1284 7-BIT BUS INTERFACES WITH 3-STATE OUTPUTS

SCAS459B – NOVEMBER 1994 – REVISED APRIL 1996

- 3-State Outputs Directly Drive Bus Lines
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ($C = 200$ pF, $R = 0$)
- Designed for the IEEE 1284-I (Level 1 Type) and IEEE 1284-II (Level 2 Type) Electrical Specifications
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and DIP (N) Packages, Ceramic Chip Carriers (FK), Flat (W), and DIP (J) Packages

description

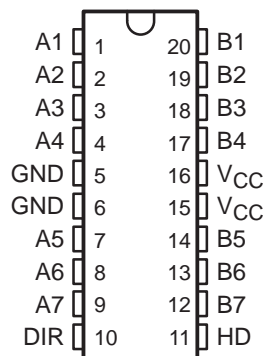
The 'ACT1284 are designed for asynchronous two-way communication between data buses. The control function minimizes external timing requirements.

The devices allow data transmission in either the A-to-B or the B-to-A direction for bits 1, 2, 3, and 4, depending on the logic level at the direction-control (DIR) input. Bits 5, 6, and 7, however, always transmit in the A-to-B direction.

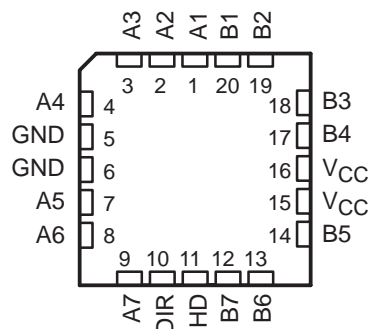
The output drive for each mode is determined by the high drive (HD) control pin. When HD is high, the high drive is delivered by the totem-pole configuration, and when HD is low, the outputs are open drain. This meets the drive requirements as specified in the IEEE 1284-I (level 1 type) and the IEEE 1284-II (level 2 type) parallel peripheral-interface specification.

The SN54ACT1284 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ACT1284 is characterized for operation from 0°C to 70°C .

SN54ACT1284 . . . J OR W PACKAGE
SN74ACT1284 . . . DB, DW, N, OR PW PACKAGE
(TOP VIEW)



FK PACKAGE
(TOP VIEW)



FUNCTION TABLE

INPUTS		OUTPUT	MODE
DIR	HD		
L	L	Open drain	A to B: Bits 5, 6, 7
		Totem pole	B to A: Bits 1, 2, 3, 4
L	H	Totem pole	B to A: Bits 1, 2, 3, 4 and A to B: Bits 5, 6, 7
H	L	Open drain	A to B: Bits 1, 2, 3, 4, 5, 6, 7
H		Totem pole	A to B: Bits 1, 2, 3, 4, 5, 6, 7



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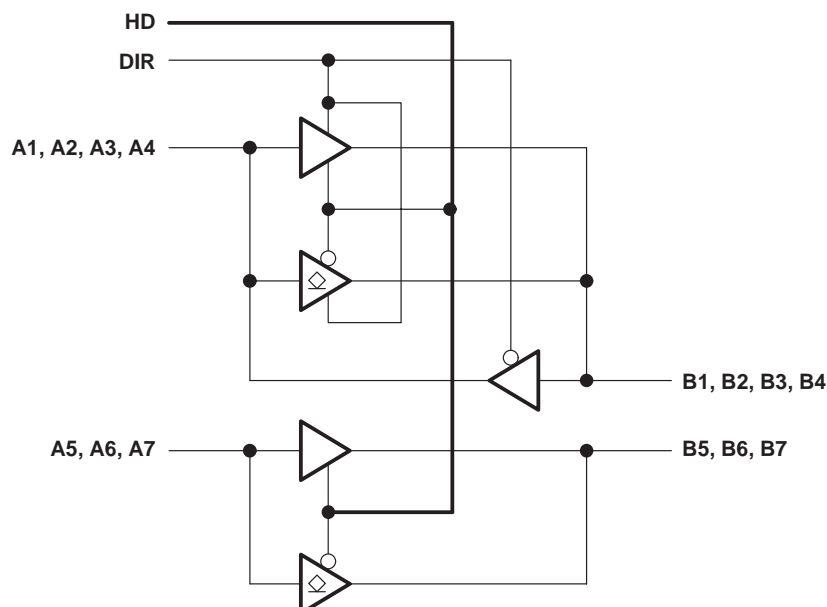
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**TEXAS
INSTRUMENTS**

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 7 V
B-port input and output voltage range, V_I and V_O (see Notes 1 and 2)	–2 V to 7 V
A-port input and output voltage range, V_I and V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V_{CC} or GND	±200 mA
Package thermal impedance, θ_{JA} (see Note 3): DB package	115°C/W
DW package	97°C/W
N package	67°C/W
PW package	128°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 2. The ac input voltage pulsewidth is limited to 20 ns if the input voltage goes more negative than –0.5 V.
 3. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

SN54ACT1284, SN74ACT1284

7-BIT BUS INTERFACES

WITH 3-STATE OUTPUTS

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recommended operating conditions

			SN54ACT1284		SN74ACT1284		UNIT
			MIN	MAX	MIN	MAX	
V _{CC}	Supply voltage		4.7	5.5	4.7	5.5	V
V _{IH}	High-level input voltage		2		2		V
V _{IL}	Low-level input voltage			0.8		0.8	V
V _I	Input voltage		0	V _{CC}	0	V _{CC}	V
V _O	Open drain output voltage	HD low	0	5.5	0	5.5	V
I _{OH}	High-level output current	B port, HD high		–14		–14	mA
		A port		–4		–4	
I _{OL}	Low-level output current	B port		14		14	mA
		A port		4		4	
T _A	Operating free-air temperature		–55	125	0	70	°C

electrical characteristics over recommended ranges of operating free-air temperature and supply voltage (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC} [†]	SN54ACT1284			SN74ACT1284			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{hys}	Input hysteresis	V _{IT+} – V _{IT–} for all inputs	5 V	0.4			0.4			V
			4.7 V	0.2			0.2			
V _{OH}	B port	I _{OH} = –14 mA	4.7 V	2.4			2.4			V
	A port	I _{OH} = –50 μA	MIN to MAX	V _{CC} –0.2			V _{CC} –0.2			
		I _{OH} = –4 mA	4.7 V	3.7			3.7			
V _{OL}	B port	I _{OL} = 14 mA	4.7 V			0.4			0.4	V
	A port	I _{OL} = 50 μA	4.7 V			0.2			0.2	
		I _{OL} = 4 mA				0.4			0.4	
I _I		V _I = V _{CC} or GND	5.5 V			±1			±1	μA
I _{OZ}	A or B ports [‡]	V _O = V _{CC} or GND	5.5 V			±20			±20	μA
I _{OFF}	B port	V _I or V _O ≤ 7 V	0 V			±100			±100	μA
I _{CC}		V _I = V _{CC} or GND, I _O = 0	5.5 V			1.5			1.5	mA
C _i	Control inputs	V _I = V _{CC} or GND	5 V		4			4		pF
C _{io}	A or B ports	V _O = V _{CC} or GND	5 V		12			12		pF
Z _O	B port	I _{OH} = –20 mA, I _{OH} = –50 mA	5 V	8		30	8		30	Ω

[†] For I/O ports, the parameter I_{OZ} includes the input leakage current I_I.

[‡] For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

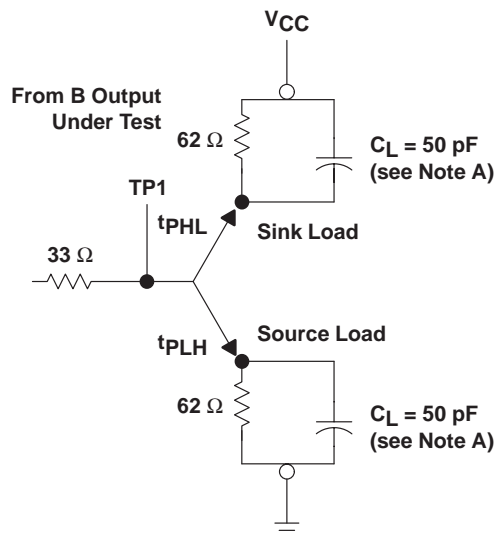
PARAMETER		FROM (INPUT)	TO (OUTPUT)	SN54ACT1284		SN74ACT1284		UNIT
				MIN	MAX	MIN	MAX	
t _{PLH}	Totem pole	A or B	B or A	1	20	1	20	ns
t _{PHL}				1	20	1	20	
SR	Totem pole	B output		0.05	0.4	0.05	0.4	V/ns
t _{pd} (EN)	Totem pole	HD	B	1	20	1	20	ns
t _{pd} (DIS)				1	20	1	20	
t _r , t _f	Open drain	A	B	120		120		ns

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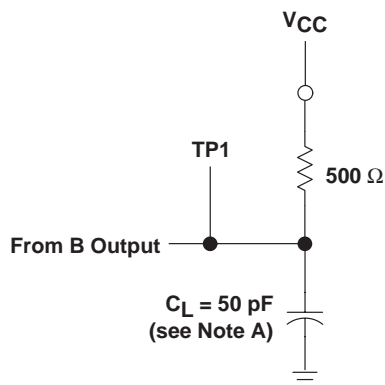
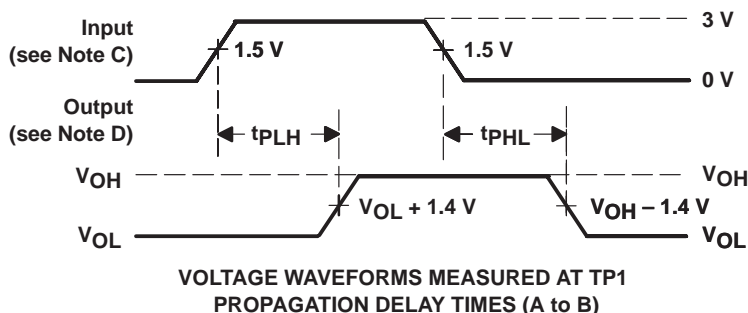


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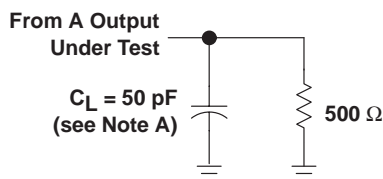
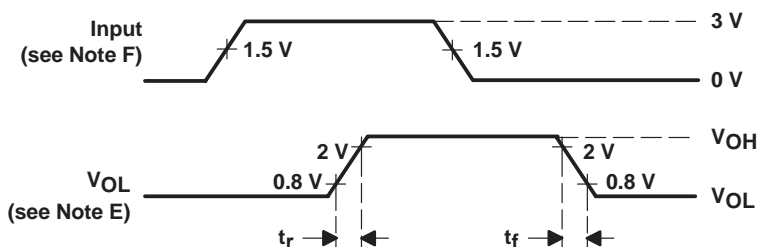
PARAMETER MEASUREMENT INFORMATION



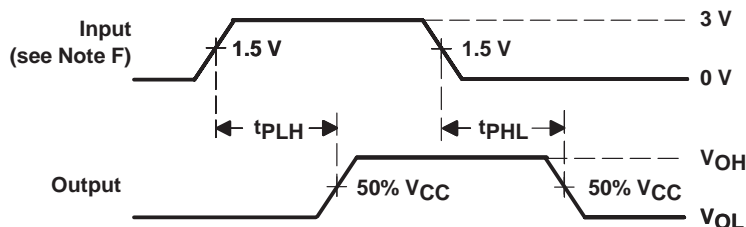
A-TO-B LOAD (totem pole)



A-TO-B LOAD (open drain)



B-TO-A LOAD (totem pole)



- NOTES: A. CL includes probe and jig capacitance.
B. The outputs are measured one at a time with one transition per measurement.
C. Input rise and fall times are 3 ns, 150 ns < pulsewidth < 10 μs for both low-to-high and high-to-low transitions.
D. Slew rate is defined as 10% and 90% of the transition times.
E. Rise and fall times, open drain, are <120 ns.
F. Input rise and fall times are 3 ns.

Figure 1. Load Circuits and Voltage Waveforms

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